## Search Notes



	Appl	icati	on/	Con	trol	No.
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10710855

### Examiner

Heyi, Henok G

# Applicant(s)/Patent Under Reexamination

CHANG, SUNG-SAN

#### **Art Unit**

2609

# SEARCHED

Class		Subclass	Date	Examiner
720	601	•	06/21/2007	Henok heyi
	602		06/21/2007	Henok heyi

SEARCH NOTES				
Search Notes	Date	Examiner		
Conducted both classified and text search using EAST. I have also used google patents. I got help in search, claim interpretation and analysis from the class assistant trainer, Krista. I also asked a primary examiner, Tan Dinh, to direct me to the right classification of this application because it was not properly classifed.	06/21/2007	Henok Heyi		

	INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner		

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